

<b>Notice of References Cited</b>	Application/Control No. 10/698,327	Applicant(s)/Patent Under Reexamination CLARK, EDWARD ALAN	
	Examiner Quynh H. Nguyen	Art Unit 2614	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0033684	02-2005	Benedyk et al.	705/039
*	B	US-2001/0009014	07-2001	Savage et al.	709/204
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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